


Search Notes 	Application/Control No. 10520151	Applicant(s)/Patent Under Reexamination KURITA, TADASHI
	Examiner GELEK TOPGYAL	Art Unit 2621

SEARCHED			
Class	Subclass	Date	Examiner
386	46,65,66,95,98,102,109	3/13/2008	GT

SEARCH NOTES		
Search Notes	Date	Examiner
Thai Tran: Determined any subsampling system used for PIP processing meets the claimed invention.	3/13/2008	GT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner